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## MARIA – The high-intensity polarized neutron reflectometer of JCNS

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The high-intensity reflectometer MARIA of JCNS is installed in the neutron guide hall of the FRM-II reactor, and is using a velocity selector ( $4.5\text{\AA} < \lambda < 40\text{\AA}$ ) with a resolution of 10%. By using Fermi-Chopper the wavelength resolution can be increased to 1% or 3%. The beam is polarized by a double-reflecting super mirror ( $4.5\text{\AA} < \lambda < 12\text{\AA}$ ) and in the vertical direction the elliptically focusing neutron guide increases the flux at the sample position reducing the required sample size or measuring time. A flexible Hexapod, as sample table, can be equipped with an electromagnet (up to 1.1T) or a cryomagnet (up to 5T), low temperature sample environment, a UHV-chamber ( $10^{-10}$  mbar range) for the measurement of Oxide MBE samples, and various soft matter solid/liquid interface cells connected to a “sample robot” for automatic solvent contrast exchange and remote controlled heating/cooling. Together with the  $400 \times 400 \text{ mm}^2$  position sensitive detector and a time-stable  $^3\text{He}$  polarization spin filter based on SEOP technique, the instrument is well suited for investigating specular reflectivity (up to 7-8 orders of magnitude), off-specular scattering from structures down to the monolayer regime. The GISANS option can be used to investigate lateral correlations in the nm range. Due to the large detector even grazing incidence diffraction measurements are possible. Furthermore the high intensity allows for kinetic measurements down to a few seconds over a dynamic range of 3-4 orders.

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